

# **CGHV22100**

### 100 W, 1800-2200 MHz, GaN HEMT for LTE

Cree's CGHV22100 is a gallium nitride (GaN) high electron mobility transistor (HEMT) is designed specifically for high efficiency, high gain and wide bandwidth capabilities, which makes the CGHV22100 ideal for 1.8 - 2.2 GHz LTE, 4G Telecom and BWA amplifier applications. The transistor is input matched and supplied in a ceramic/metal flange package.



Package Type: 440162 and 440161 PN: CGHV22100F and CGHV22100P

# Typical Performance Over 1.8 - 2.2 GHz ( $T_c = 25$ °c) of Demonstration Amplifier

Parameter	1.8 GHz	2.0 GHz	2.2 GHz	Units
Gain @ 44 dBm	18.7	20.7	22.0	dB
ACLR @ 44 dBm	-37.8	-37.1	-35.1	dBc
Drain Efficiency @ 44 dBm	35.4	31.7	30.6	%

#### Note:

Measured in the CGHV22100-TB amplifier circuit, under WCDMA 3GPP test model 1, 64 DPCH, 45% clipping,  $PAR = 7.5 \text{ dB} \oplus 0.01\%$  Probability on CCDF.

#### **Features**

ROHS

- 1.8 2.2 GHz Operation
- 20 dB Gain
- -35 dBc ACLR at 25 W  $P_{AVE}$
- 31-35 % Efficiency at 25 W P
- High Degree of DPD Correction Can be Applied



# Absolute Maximum Ratings (not simultaneous) at 25°C Case Temperature

Parameter	Symbol	Rating	Units	Units
Drain-Source Voltage	$V_{\scriptscriptstyle DSS}$	125	Volts	25°C
Gate-to-Source Voltage	$V_{GS}$	-10, +2	Volts	25°C
Storage Temperature	$T_{STG}$	-65, +150	°C	
Operating Junction Temperature <sup>3</sup>	T <sub>3</sub>	225	°C	
Maximum Forward Gate Current	$I_{GMAX}$	16	mA	25°C
Maximum Drain Current <sup>1</sup>	I <sub>DMAX</sub>	6	А	25°C
Soldering Temperature <sup>2</sup>	T <sub>s</sub>	245	°C	
Screw Torque	τ	80	in-oz	
Thermal Resistance, Junction to Case <sup>3</sup>	$R_{_{\theta JC}}$	2.34	°C/W	85°C, P <sub>DISS</sub> = 48 W
Thermal Resistance, Junction to Case <sup>4</sup>	$R_{_{\theta  m JC}}$	2.95	°C/W	$85^{\circ}$ C, $P_{DISS} = 48 \text{ W}$
Case Operating Temperature <sup>5</sup>	T <sub>c</sub>	-40, +150	°C	

#### Note:

- <sup>1</sup> Current limit for long term, reliable operation.
- <sup>2</sup> Refer to the Application Note on soldering at <a href="http://www.cree.com/rf/document-library">http://www.cree.com/rf/document-library</a>
- <sup>3</sup> Measured for the CGHV22100P
- <sup>4</sup> Measured for the CGHV22100F
- <sup>5</sup> See also, the Power Dissipation De-rating Curve on Page 4.

# Electrical Characteristics ( $T_c = 25$ °C)

Characteristics	Symbol	Min.	Тур.	Max.	Units	Conditions
DC Characteristics <sup>1</sup>	DC Characteristics <sup>1</sup>					
Gate Threshold Voltage	$V_{GS(th)}$	-3.8	-3.0	-2.3	$V_{DC}$	$V_{DS} = 10 \text{ V, } I_{D} = 16 \text{ mA}$
Gate Quiescent Voltage	$V_{GS(\mathtt{Q})}$	-	-2.7	-	$V_{_{DC}}$	$V_{DS} = 50 \text{ V, } I_{D} = 0.5 \text{ A}$
Saturated Drain Current <sup>2</sup>	$I_{\scriptscriptstyle \sf DS}$	12	14.4	-	Α	$V_{DS} = 6.0 \text{ V}, V_{GS} = 2.0 \text{ V}$
Drain-Source Breakdown Voltage	$V_{_{BR}}$	125	-	-	$V_{_{DC}}$	$V_{GS} = -8 \text{ V, } I_{D} = 16 \text{ mA}$
RF Characteristics <sup>3</sup> ( $T_c = 25$ °C, $F_o$	= 2.17 GHz เ	ınless otherv	vise noted)			
Gain⁴	G	19.75	22	-	dB	$V_{DD}$ = 50 V, $I_{DQ}$ = 0.5 A, $P_{OUT}$ = 44 dBm
WCDMA Linearity⁴	ACLR	-	-35	-31	dBc	$V_{DD} = 50 \text{ V, } I_{DQ} = 0.5 \text{ A, } P_{OUT} = 44 \text{ dBm}$
Drain Efficiency <sup>4</sup>	η	26.5	30.5	-	%	$V_{DD}$ = 50 V, $I_{DQ}$ = 0.5 A, $P_{OUT}$ = 44 dBm
Output Mismatch Stress	VSWR	-	-	10 : 1	Ψ	No damage at all phase angles, $V_{DD} = 50 \text{ V}$ , $I_{DQ} = 0.5 \text{ A}$ , $P_{OUT} = 100 \text{ W}$ Pulsed
Dynamic Characteristics						
Input Capacitance <sup>5</sup>	$C_{GS}$	-	66	-	pF	$V_{DS}$ = 50 V, $V_{gs}$ = -8 V, f = 1 MHz
Output Capacitance <sup>5</sup>	$C_{\scriptscriptstyle{DS}}$	-	8.7	-	pF	$V_{DS}$ = 50 V, $V_{gs}$ = -8 V, f = 1 MHz
Feedback Capacitance	$C_GD$	-	0.47	-	pF	$V_{DS} = 50 \text{ V}, V_{gs} = -8 \text{ V}, f = 1 \text{ MHz}$

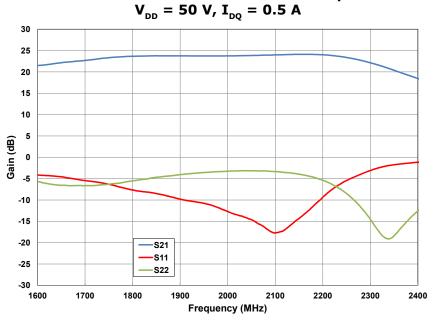
#### Notes:

- <sup>1</sup> Measured on wafer prior to packaging.
- <sup>2</sup> Scaled from PCM data.
- <sup>3</sup> Measured in CGHV22100-TB.
- <sup>4</sup> Single Carrier WCDMA, 3GPP Test Model 1, 64 DPCH, 45% Clipping, PAR = 7.5 dB @ 0.01% Probability on CCDF.
- <sup>5</sup> Includes package and internal matching components.



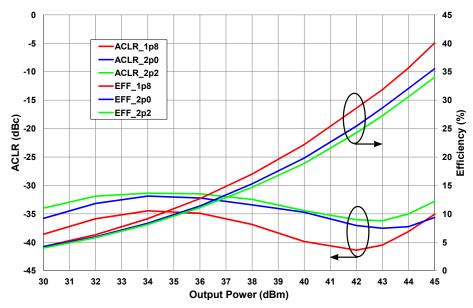
### **Typical Performance**

Figure 1. - Small Signal Gain and Return Losses vs Frequency for the CGHV22100 measured in CGHV22100-TB Amplifier Circuit



### **Typical Linear Performance**

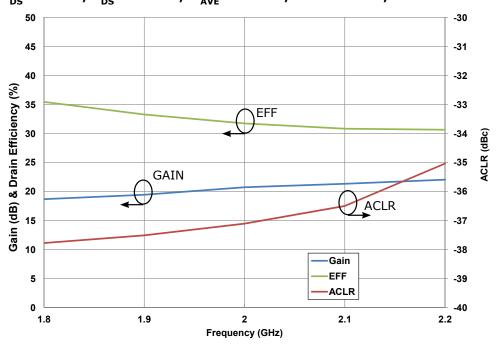
Figure 2. - Typical Drain Efficiency and ACLR vs Output Power of the CGHV22100 measured in CGHV22100-TB Amplifier Circuit.  $V_{\rm DS}=50~V,~I_{\rm DS}=0.5~A,~1c~WCDMA,~PAR=7.5~dB$ 



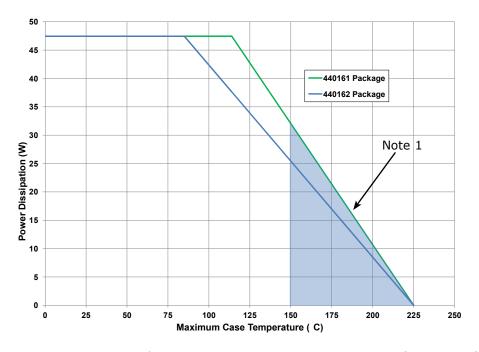


#### **Typical Performance**

Figure 3. - Typical Gain, Drain Efficiency and ACLR vs Frequency of CGHV22100 measured in CGHV22100-TB Amplifier Circuit.  $V_{DS}=50~V,~I_{DS}=0.5~A,~P_{AVE}=25~W,~1c~WCDMA,~PAR=7.5~dB$ 



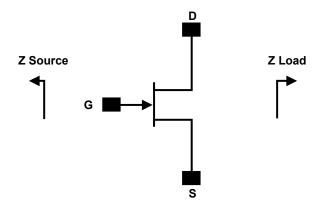
### **CGHV22100 Power Dissipation De-rating Curve**



Note 1. Area exceeds Maximum Case Operating Temperature (See Page 2).



# **Source and Load Impedances**



Frequency (MHz)	Z Source	Z Load
1800	4.50 + j0.91	5.21 - j2.58
1900	5.20 + j1.15	5.01 - j2.09
2000	6.02 + j1.03	4.85 - j1.61
2100	6.75 + j0.42	4.70 - j1.12
2200	7.03 - j0.64	4.58 - j0.62

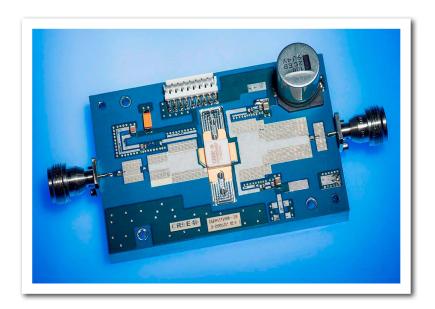
Note¹:  $V_{\text{DD}}$  = 50 V,  $I_{\text{DQ}}$  = 0.5 A. In the 440162 package. Note²: Impedances are extracted from CGHV22100-TB demonstration circuit and are not source and load pull data derived from transistor.



# **CGHV22100-TB Demonstration Amplifier Circuit Bill of Materials**

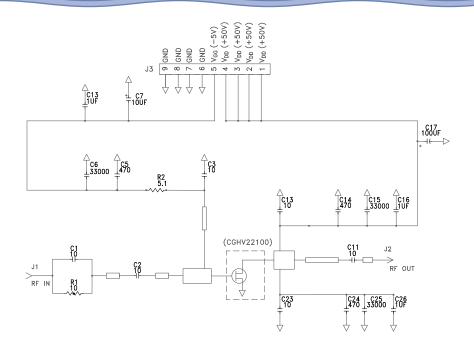
Designator	Description	Qty
R1	RES, 1/16 W, 0603, 1%, 10.0 OHMS	1
R2	RES, 1/16 W, 0603, 1%, 5.1 OHMS	1
C4, C14, C24	CAP, 470 pF, 5%, 100 V, 0603, X	3
C6,C16, C26	CAP, 1.0 UF, 100 V, 10%, x7R, 121	3
C17, C27	CAP, 100 UF, 20%, 160 V, ELEC	2
C7	CAP, 10 UF, 16 V, TANTALUM, 2312	1
C1, C2, C3, C13, C23	CAP, 10.0 pF, 5%, 0603, ATC	5
C5, C15, C25	CAP, 33000 pF, 0805, 100 V, X7R	3
C11	CAP, 10 pF, 5%, 250 V, 0805, A	1
J1, J2	CONN, N, FEM, W/.500 SMA FLNG	2
J3	HEADER RT>PLZ .1CEN LK 9POS	1
	BASEPLATE, CGH35120	
	PCB, CGHV22100F, RO4350	1
	2-56 SOC HD SCREW 1/4 SS	4
	#2 SPLIT LOCKWASHER SS	4
	CGHV22100F	1

# **CGHV22100-TB Demonstration Amplifier Circuit**

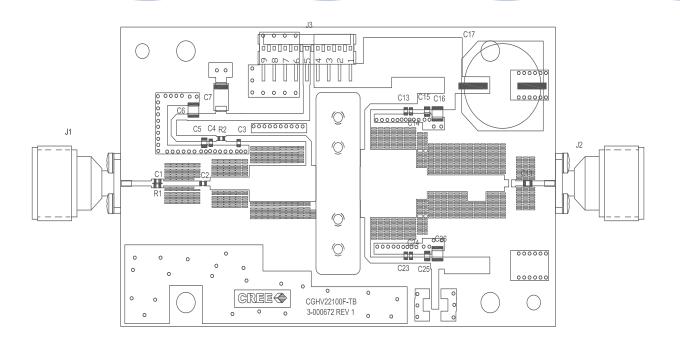




### **CGHV22100-TB Demonstration Amplifier Circuit Schematic**

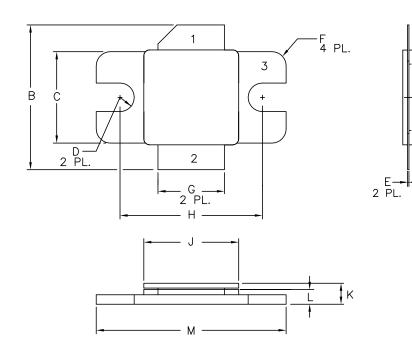


### **CGHV22100-TB Demonstration Amplifier Circuit Outline**





# **Product Dimensions CGHV22100 (Package Type - 440162)**



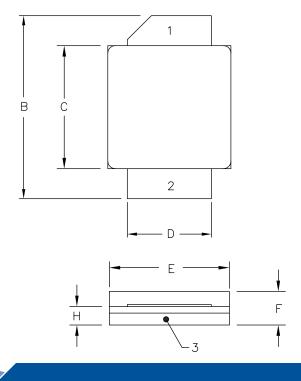
#### NOTES:

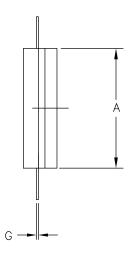
- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.
- 3. ADHESIVE FROM LID MAY EXTEND A MAXIMUM OF 0.020" BEYOND EDGE OF LID.
- LID MAY BE MISALIGNED TO THE BODY
   OF THE PACKAGE BY A MAXIMUM OF 0.008" IN
   ANY DIRECTION.

	INCHES		MILLIM	IETERS
DIM	MIN	MAX	MIN	MAX
Α	.395	.405	10.03	10.29
В	.580	.620	14.73	15.75
С	.380	.390	9.65	9.91
D	.055	.065	1.40	1.65
E	.004	.006	0.10	0.15
F	.055	.065	1.40	1.65
G	.275	.285	6.99	7.24
Н	.595	.605	15.11	15.37
J	.395	.405	10.03	10.29
K	.129	.149	3.28	3.78
L	.053	.067	1.35	1.70
М	.795	.805	20.19	20.45

PIN 1. GATE PIN 2. DRAIN PIN 3. SOURCE

### **Product Dimensions CGHV22100 (Package Type — 440161)**





PIN 1. GATE PIN 2. DRAIN PIN 3. SOURCE

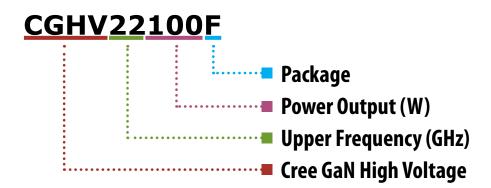
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F	.129	.149	3.28	3.78
G	.004	.006	0.10	0.15
Н	.057	.067	1.45	1.70



#### **Part Number System**



Parameter	Value	Units
Upper Frequency <sup>1</sup>	2.2	GHz
Power Output	100	W
Package	Flange	-

Table 1.

**Note**<sup>1</sup>: Alpha characters used in frequency code indicate a value greater than 9.9 GHz. See Table 2 for value.

Character Code	Code Value	
А	0	
В	1	
С	2	
D	3	
E	4	
F	5	
G	6	
Н	7	
J	8	
K	9	
Examples:	1A = 10.0 GHz 2H = 27.0 GHz	

Table 2.



#### **Disclaimer**

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